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- AC Types Feature 1.5-V to 5.5-V Operation and Balanced Noise Immunity at 30% of the Supply Voltage
- Buffered Inputs
- Incorporate Two Enable Inputs to Simplify Cascading and/or Data Reception
- Speed of Bipolar F, AS, and S, With Significantly Reduced Power Consumption
- Balanced Propagation Delays
- ±24-mA Output Drive Current
 - Fanout to 15 F Devices
- SCR-Latchup-Resistant CMOS Process and Circuit Design
- Exceeds 2-kV ESD Protection Per MIL-STD-883, Method 3015

CD54AC139...F PACKAGE CD74AC139 . . . E OR M PACKAGE (TOP VIEW) 16 NCC 1G 1A 15 T 2G Π_2 1B Пз 14 1 2A 1Y0 13 2B 4 1Y1 5 12**∏** 2Y0 1Y2 6 11 2Y1 1Y3 10 **1** 2Y2 9 2Y3 GND П 8

description/ordering information

The 'AC139 devices are dual 2-line to 4-line decoders/demultiplexers designed for 1.5-V to 5.5-V V_{CC} operation. These devices are designed to be used in high-performance memory-decoding or data-routing applications requiring very short propagation delay times. In high-performance memory systems, these decoders can be used to minimize the effects of system decoding. When used with high-speed memories utilizing a fast enable circuit, the delay times of these decoders and the enable time of the memory usually are less than the typical access time of the memory. This means that the effective system delay introduced by the decoders is negligible.

The active-low enable (\overline{G}) input can be used as a data line in demultiplexing applications. These decoders/demultiplexers feature fully buffered inputs, each of which represents only one normalized load to its driving circuit.

ORDERING INFORMATION

TA	PACKAGE [†]		PACKAGE [†]		ORDERABLE PART NUMBER	TOP-SIDE MARKING
	PDIP – E	Tube	CD74AC139E	CD74AC139E		
–55°C to 125°C	SOIC – M	Tube	CD74AC139M	AC139M		
-55 C to 125 C	SOIC - IVI	Tape and reel	CD74AC139M96	AC 139IVI		
	CDIP – F	Tube	CD54AC139F3A	CD54AC139F3A		

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

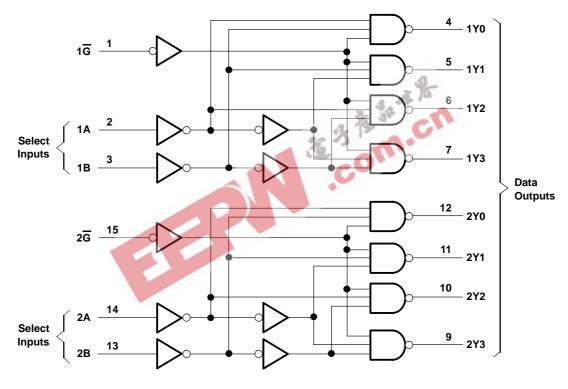


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FUNCTION TABLE (each decoder/demultiplexer)

	INPUTS OUTPUTS					
G	SEL	ECT		0011	-013	
G	В	Α	Y0	Y1	Y2	Y3
Н	Х	Х	Н	Н	Н	Н
L	L	L	L	Н	Н	Н
L	L	Н	Н	L	Н	Н
L	Н	L	Н	Н	L	Н
L	Н	Н	Н	Н	Н	L

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	0.5 V to 6 V
Input clamp current, I _{IK} (V _I < 0 V or V _I > V _{CC}) (see Note 1)	±20 mA
Output clamp current, I _{OK} (V _O < 0 V or V _O > V _{CC}) (see Note 1)	±50 mA
Continuous output current, I _O (V _O > 0 V or V _O < V _{CC})	±50 mA
Continuous current through V _{CC} or GND	±100 mA
Package thermal impedance, θ_{JA} (see Note 2): E package	67°C/W
M package	73°C/W
Storage temperature range, T _{stq}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

^{2.} The package thermal impedance is calculated in accordance with JESD 51-7.



NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

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recommended operating conditions (see Note 3)

			T _A = 25°C		–55°C to 125°C		–40°C to 85°C		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	
Vcc	Supply voltage		1.5	5.5	1.5	5.5	1.5	5.5	V
		V _{CC} = 1.5 V	1.2		1.2		1.2		
VIН	High-level input voltage	V _{CC} = 3 V	2.1		2.1		2.1		V
		V _{CC} = 5.5 V	3.85		3.85		3.85		
	Low-level input voltage	V _{CC} = 1.5 V		0.3		0.3		0.3	
V_{IL}		V _{CC} = 3 V		0.9		0.9		0.9	V
		V _{CC} = 5.5 V		1.65		1.65		1.65	
٧ _I	Input voltage		0	VCC	0	VCC	0	VCC	V
٧o	Output voltage		0	VCC	0	VCC	0	VCC	V
loh	High-level output current	V _{CC} = 4.5 V to 5.5 V		-24		-24		-24	mA
loL	Low-level output current	V _{CC} = 4.5 V to 5.5 V		24		24		24	mA
4+/4>/	Input transition rise or fall rate	V _{CC} = 1.5 V to 3 V		50		50		50	ns/V
Δt/Δv	Input transition rise or fall rate	$V_{CC} = 3.6 \text{ V to } 5.5 \text{ V}$		20		20		20	115/V

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		Vcc	T _A = 25°C		–55°C to 125°C		–40°C to 85°C		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	
		1.5 V	1.4		1.4		1.4			
		I _{OH} = -50 μA	3 V	2.9		2.9		2.9		
			4.5 V	4.4		4.4		4.4		
Voн	$V_I = V_{IH}$ or V_{IL}	$I_{OH} = -4 \text{ mA}$	3 V	2.58		2.4		2.48		V
		$I_{OH} = -24 \text{ mA}$	4.5 V	3.94		3.7		3.8		
		$I_{OH} = -50 \text{ mA}^{\dagger}$	5.5 V			3.85				
		I _{OH} = -75 mA [†]	5.5 V					3.85		
		Ι _Ο L = 50 μΑ	1.5 V		0.1		0.1		0.1	
			3 V		0.1		0.1		0.1	
	V _I = V _{IH} or V _{IL}		4.5 V		0.1		0.1		0.1	
v_{OL}		I _{OL} = 12 mA	3 V		0.36		0.5		0.44	V
		I _{OL} = 24 mA	4.5 V		0.36		0.5		0.44	
		I _{OL} = 50 mA†	5.5 V				1.65		_	
		I _{OL} = 75 mA†	5.5 V						1.65	
l _l	$V_I = V_{CC}$ or GND	-	5.5 V		±0.1		±1		±1	μΑ
Icc	$V_I = V_{CC}$ or GND,	IO = 0	5.5 V		8		160		80	μΑ
Ci					10		10		10	pF

[†] Test one output at a time, not exceeding 1-second duration. Measurement is made by forcing indicated current and measuring voltage to minimize power dissipation. Test verifies a minimum 50-Ω transmission-line drive capability at 85°C and 75-Ω transmission-line drive capability at 125°C.



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switching characteristics over recommended operating free-air temperature range, V_{CC} = 1.5 V, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	–55°C to 125°C		–40°C to 85°C		UNIT		
	(INFOT)	(001101)	MIN MAX MIN MAX 119							
tPLH	A or B	Any V	C: - 50 pE		131		119	ne		
^t PHL	A 01 B	Ally I	C _L = 50 pF	OL = 30 pr	CL = 30 pr		131		119	ns
^t PLH	G	Any Y	C: - 50 pE		131		119	nc		
t _{PHL}	9	Ally I	C _L = 50 pF			119	ns			

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	–55°0 125		–40°C to 85°C		UNIT
	(INFOT)	(0011 01)	CAFACITANCE	MIN	MAX	MIN	MAX	
tPLH	A or B	Any Y	C _L = 50 pF	3.7	14.7	3.9	13.4	ns
tPHL	AOIB	Ally I	CL = 30 pr	3.7	14.7	3.9	13.4	115
tPLH	IG	Any V	C: -50 pF	3.7	14.7	3.9	13.4	ns
^t PHL	G Any Y	$C_L = 50 pF$	3.7	14.7	3.9	13.4	110	

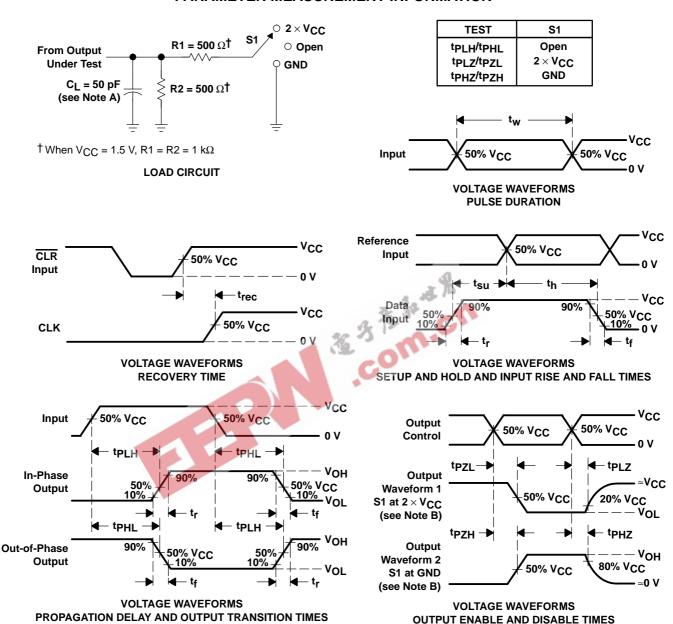
switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	–55°C to 125°C		–40°C to 85°C		UNIT
	(1141 01)	(66)1161)	OAI AOITAINOL	MIN	MAX	MIN	MAX	
t _{PLH}	A or B	Any Y	C _L = 50 pF	2.6	10.5	2.8	9.5	ns I
^t PHL	AUID	Ally 1		2.6	10.5	2.8	9.5	
t _{PLH}	G	Any Y	C: - 50 pE	2.6	10.5	2.8	9.5	ns
^t PHL	G	Ally f	C _L = 50 pF	2.6	10.5	2.8	9.5	115

operating characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

	PARAMETER	TYP	UNIT
[Power dissipation capacitance	83	pF

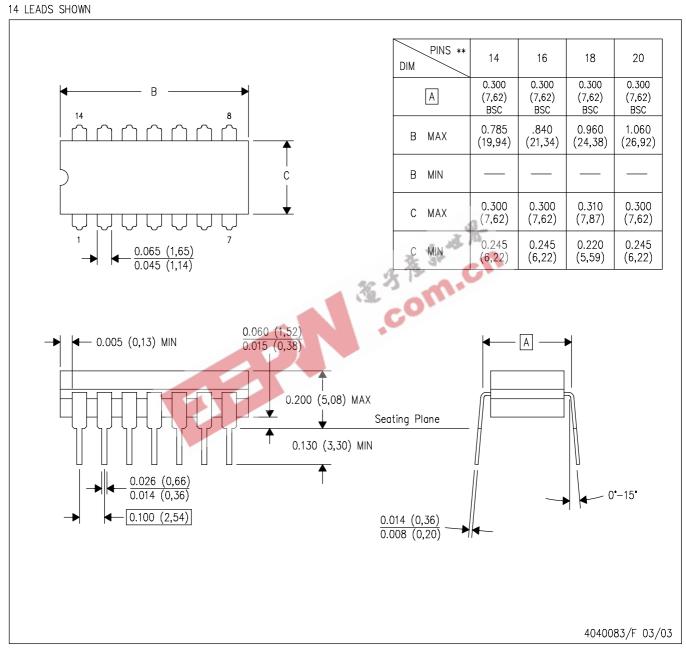
PARAMETER MEASUREMENT INFORMATION



- NOTES: A. C_L includes probe and test-fixture capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, $t_f = 3$ ns, $t_f = 3$ ns. Phase relationships between waveforms are arbitrary.
 - D. For clock inputs, f_{max} is measured with the input duty cycle at 50%.
 - E. The outputs are measured one at a time with one input transition per measurement.
 - F. tpLH and tpHL are the same as tpd.
 - G. t_{PZL} and t_{PZH} are the same as t_{en} .
 - H. tpLz and tpHz are the same as tdis.
 - I. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms





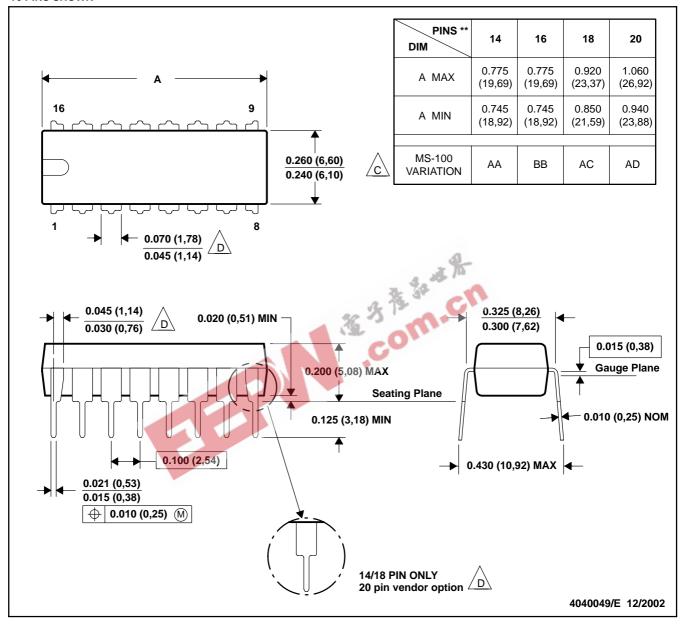
NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

Falls within JEDEC MS-001, except 18 and 20 pin minimum body Irngth (Dim A).

The 20 pin end lead shoulder width is a vendor option, either half or full width.

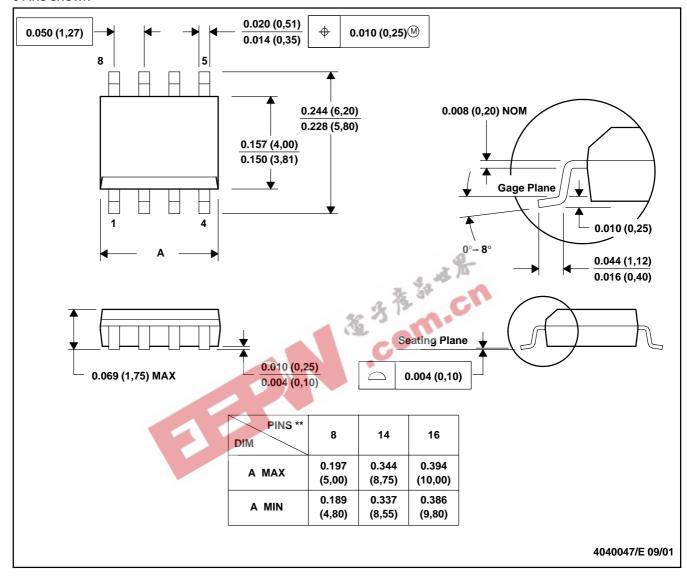


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D (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

8 PINS SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-012

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